## NSN 5210-01-468-3123

Spring Micrometer - Page 1 of 1



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Used to measure coarse and extra coarse replica tape,	such as testex press-o-film,	to determine peak to valley height (profile/cleanliness
of blast cleaned surfaces		

Tullottorial Description.
Used to measure coarse and extra coarse replica tape, such as testex press-o-film, to determine peak to valley height (profile/cleanliness)
of blast cleaned surfaces
Shelf Life:
N/a
Unit Of Measure:
<del></del>
Demilitarization:
No